

Notice of References Cited	Application/Control No. 10/601,082	Applicant(s)/Patent Under Reexamination MOELLER-JENSEN, PETER	
	Examiner John B. Sotomayor	Art Unit 3662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,603,952	09-1971	Smith, Millard F.	340/539.26
	B	US-3,899,213	08-1975	Fantasia et al.	250/301
	C	US-4,918,456	04-1990	Druzhinin et al.	342/26
	D	US-			
	E	US-4,963,024	10-1990	Ulich, Bobby L.	356/342
	F	US-5,296,711 A	03-1994	Leonard et al.	250/372
	G	US-5,381,442 A	01-1995	Brown et al.	374/7
	H	US-5,532,679 A	07-1996	Baxter, Jr., John F.	340/539.26
	I	US-5,633,644	05-1997	Schussler et al.	342/455
	J	US-5,672,007	09-1997	Brown et al.	374/7
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Microwave Remote Sensing Of Oil Spills In Ocean", Raizer, V.Yu.; Smirnov, A.V.; Etkin, V.S.; Geoscience and Remote Sensin Symposium. IGARSS '91. 'Remote Sensing: Global Monitoring for Earth Management', Int'l, Vol: 3, June 3-6, 1991 Ps:1319 - 1319
	V	"Detection and classification of subsurface objects in a marine environment by the use of a lidar system", Cianciotto, F.T.P.; Aerospace and Electronics Conference, 1997. NAECON 1997., Proceedings of the IEEE Nat'l, Vol: 1, 14-17 July 1997 Ps:463 - 468
	W	"Oil-spill monitoring using microwave radiometer", Shi Zhifu; Zhao Kai; Liu Baojiang; Liu Futao; Geoscience and Remote Sensing Symposium. IGARSS '02. 2002 IEEE Int'l, Vol: 5, 24-28 June 2002 Pages:2980 - 2982
	X	"Polarimetric radar signatures of oil slicks for measuring slick thickness", Kasilingam, D.; Combined Optical-Microwave Earth and Atmosphere Sensing. Conf. Proceedings., Second Topical Symposium on, 3-6 April 1995 P:94

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.